



Johns Hopkins Technology Transfer

Sickness Impact Profile

ROI Number

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Field

Health and Safety

Patent Status

Copyright

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Sickness Impact Profile (SIP) is an assessment tool that consists of 136 questions and measures behaviorally-based health status. It has been validated and used for over 30 years. The SIP can be self- or interviewer-administered and asks respondents to endorse items that describe their everyday activity and are related to their health. Scoring is based on the number and type of items endorsed.

Commercial Use

Health status questionnaire

Reference

Bergner M et al. (1981) The Sickness Impact Profile: development and final revision of a health status measure. *Med Care*. 19(8):787-805